



U74LVC2G04

CMOS IC

DUAL INVERTER

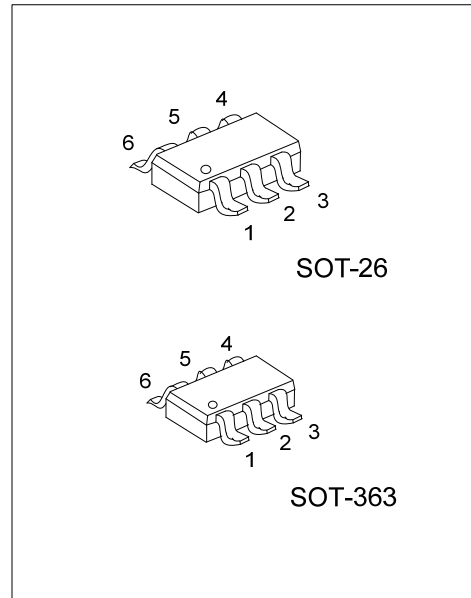
DESCRIPTION

The **U74LVC2G04** is a dual inverter gate and it provides the Boolean function $Y = \overline{A}$ in positive logic.

This device has power-down protective circuit to prevent the device from destruction when it is powered down.

FEATURES

- * Operate From 1.65V To 5.5V
- * Inputs Accept Voltages To 5.5V
- * High Noise Immunity
- * Low Power Dissipation
- * Max t_{PD} Of 3.2 ns At 5V

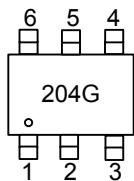


ORDERING INFORMATION

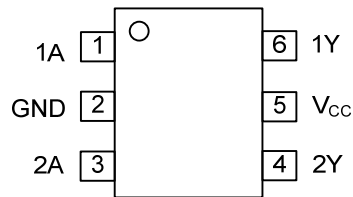
Ordering Number	Package	Packing
U74LVC2G04G-AG6-R	SOT-26	Tape Reel
U74LVC2G04G-AL6-R	SOT-363	Tape Reel

<p>U74LVC2G04G-AG6-R</p> <p>(1) Packing Type</p> <p>(2) Package Type</p> <p>(3) Green Package</p>	<p>(1) R: Tape Reel</p> <p>(2) AG6: SOT-26, AL6: SOT-363</p> <p>(3) G: Halogen Free and Lead Free</p>
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MARKING



■ PIN CONFIGURATION

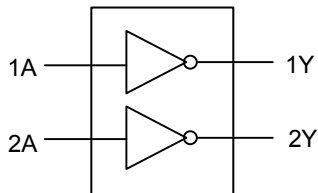


■ FUNCTION TABLE

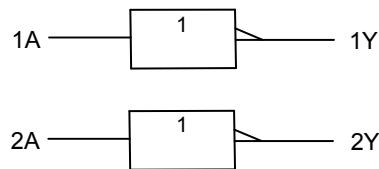
INPUT(nA)	OUTPUT(nY)
H	L
L	H

Note: H: HIGH voltage level; L: LOW voltage level.

■ LOGIC DIAGRAM (positive logic)



Logic symbol



IEC logic symbol

■ ABSOLUTE MAXIMUM RATING

PARAMETER	SYMBOL	RATINGS	UNIT
Supply Voltage	V_{CC}	-0.5 ~ +6.5	V
Input Voltage	V_{IN}	-0.5 ~ +6.5	V
Output Voltage	Active Mode	-0.5 ~ $V_{CC} + 0.5$	V
	Power-Down Mode	-0.5 ~ +6.5	V
V_{CC} or GND Current	I_{CC}	±100	mA
Continuous Output Current ($V_{OUT}=0$ to V_{CC})	I_{OUT}	±50	mA
Input Clamp Current ($V_{IN}<0$)	I_{IK}	-50	mA
Output Clamp Current ($V_{OUT}>V_{CC}$ or $V_{OUT}<0$)	I_{OK}	±50	mA
Power Dissipation ($T_A=-40^{\circ}C \sim +125^{\circ}C$)	P_D	300	mW
Operating Junction Temperature	T_J	-40 ~ +125	$^{\circ}C$
Storage Temperature	T_{STG}	-65 ~ +150	$^{\circ}C$

Note: Absolute maximum ratings are those values beyond which the device could be permanently damaged. Absolute maximum ratings are stress ratings only and functional device operation is not implied.

■ RECOMMENDED OPERATING CONDITIONS

PARAMETER	SYMBOL	MIN	TYP	MAX	UNIT
Supply Voltage	V_{CC}	1.65		5.5	V
Input Voltage	V_{IN}	0		5.5	V
Output Voltage	Active Mode	0		V_{CC}	V
	Power-Down Mode	0		5.5	V
Input Transition Rise or Fall Rate	$V_{CC}=1.65V$ to $2.7V$	0		20	ns/V
	$V_{CC}=2.7V$ to $5.5V$	0		10	ns/V

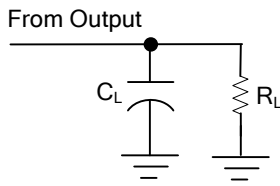
■ ELECTRICAL CHARACTERISTICS ($T_A=25^{\circ}C$, unless otherwise specified)

PARAMETER	SYMBOL	TEST CONDITIONS	MIN	TYP	MAX	UNIT
High-level Input Voltage	V_{IH}	$V_{CC}=1.65V \sim 1.95V$	$0.65 \times V_{CC}$			V
		$V_{CC}=2.3V \sim 2.7V$	1.7			V
		$V_{CC}=2.7V \sim 3.6V$	2			V
		$V_{CC}=4.5V \sim 5.5V$	$0.7 \times V_{CC}$			V
Low-level Input Voltage	V_{IL}	$V_{CC}=1.65V \sim 1.95V$			$0.35 \times V_{CC}$	V
		$V_{CC}=2.3V \sim 2.7V$			0.7	V
		$V_{CC}=2.7V \sim 3.6V$			0.8	V
		$V_{CC}=4.5V \sim 5.5V$			$0.3 \times V_{CC}$	V
High-Level Output Voltage	V_{OH}	$V_{CC}=1.65 \sim 5.5V, I_{OH}=-100\mu A$	$V_{CC}-0.1$			V
		$V_{CC}=1.65V, I_{OH}=-4mA$	1.2			V
		$V_{CC}=2.3V, I_{OH}=-8mA$	1.9			V
		$V_{CC}=2.7V, I_{OH}=-12mA$	2.2			V
		$V_{CC}=3.0V, I_{OH}=-24mA$	2.3			V
Low-Level Output Voltage	V_{OL}	$V_{CC}=1.65 \sim 5.5V, I_{OL}=100\mu A$			0.1	V
		$V_{CC}=1.65V, I_{OL}=4mA$			0.45	V
		$V_{CC}=2.3V, I_{OL}=8mA$			0.3	V
		$V_{CC}=2.7V, I_{OL}=12mA$			0.4	V
		$V_{CC}=3.0V, I_{OL}=24mA$			0.55	V
Input Leakage Current	$I_{I(LEAK)}$	$V_{CC}=5.5V, V_{IN}=5.5V$ or GND		±0.1	±5	μA
Power OFF Leakage Current	I_{OFF}	$V_{CC}=0V, V_{IN}$ or $V_{OUT}=5.5V$		±0.1	±10	μA
Quiescent Supply Current	I_Q	$V_{CC}=5.5V, V_{IN}=V_{CC}$ or GND, $I_{OUT}=0$		0.1	10	μA
Additional Quiescent Supply Current Per Input Pin	ΔI_{CC}	$V_{CC}=2.3 \sim 5.5V$, One input at $V_{CC}-0.6V$, Other inputs at V_{CC} or GND		5	500	μA

■ SWITCHING CHARACTERISTICS ($T_A = 25^\circ\text{C}$, unless otherwise specified)

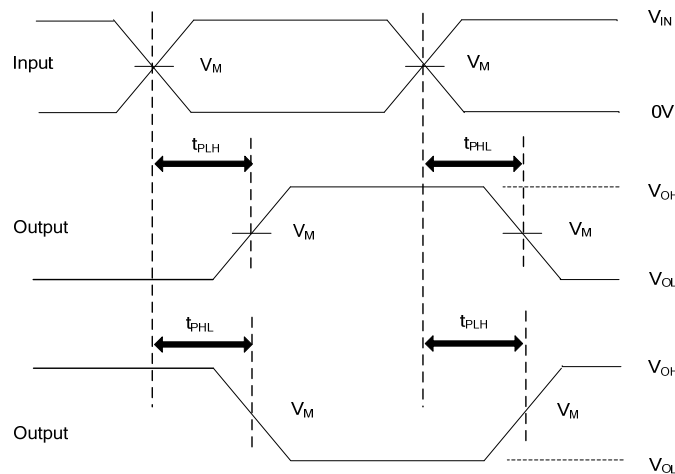
PARAMETER	SYMBOL	TEST CONDITIONS	MIN	TYP	MAX	UNIT	
Propagation delay from input (A) to output(Y)	t_{PLH}	$C_L = 30\text{pF}$	$V_{CC} = 1.8 \pm 0.15\text{V}$, $R_L = 1\text{K}\Omega$	1.0	3.5	8.0	ns
			$V_{CC} = 2.5 \pm 0.2\text{V}$, $R_L = 500\Omega$	1.0	2.2	4.4	ns
	t_{PHL}	$C_L = 50\text{pF}$	$V_{CC} = 2.7\text{V}$, $R_L = 500\Omega$	1.0	2.7	5.2	ns
			$V_{CC} = 3.3 \pm 0.3\text{V}$, $R_L = 500\Omega$	0.5	2.7	4.1	ns
			$V_{CC} = 5 \pm 0.5\text{V}$, $R_L = 500\Omega$	1.0	1.9	3.2	ns

■ TEST CIRCUIT AND WAVEFORMS



TEST CIRCUIT

V_{CC}	Inputs		V_M	C_L	R_L
	V_{IN}	t_R, t_F			
1.8V±0.15V	V_{CC}	≤2ns	$V_{CC}/2$	30pF	1KΩ
2.5V±0.2V	V_{CC}	≤2ns	$V_{CC}/2$	30pF	500Ω
2.7V	2.7V	≤2.5ns	1.5V	50pF	500Ω
3.3V±0.3V	2.7V	≤2.5ns	1.5V	50pF	500Ω
5V±0.5V	V_{CC}	≤2.5ns	$V_{CC}/2$	50pF	500Ω



PROPAGATION DELAY TIMES

- Notes: 1. C_L includes probe and jig capacitance.
 2. All input pulses are supplied by generators having the following characteristics: PRR ≤10MHz, $Z_O=50\Omega$.

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